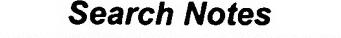


Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/564,453	MASUDA ET AL.
	Examiner	Art Unit
	John S. Chu	1752

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
430	190,191	6/20/66	JSC
430	192		
430	193,326		